

Implementing IEEE 1641 – Compilation Techniques



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A Process from *Signal* Requirement *to* Platform Native *Driver* Code

- ❑ In contrast to **previous run-time** implementations
- ❑ **Proved** through a recent **IEEE 1641 study**, sponsored by the **UK MoD**
 - Example tests; **Gain** and **1 dB Compression Point**, for a mobile communications device
 - Tests written as 1641 in a **C# carrier** language
- ❑ **IEEE ATML Capability description** of test resources used to determine suitable test resources
- ❑ An XML schema is described to describe the translation from IEEE 1641 Signals to test resources' IVI driver calls
- ❑ Tests translated to IVI driver functions, then incorporated into a C# program

Effectively, 'compiling' the IEEE 1641 Signals into IVI Driver code

Implementing IEEE 1641 – Compilation Techniques

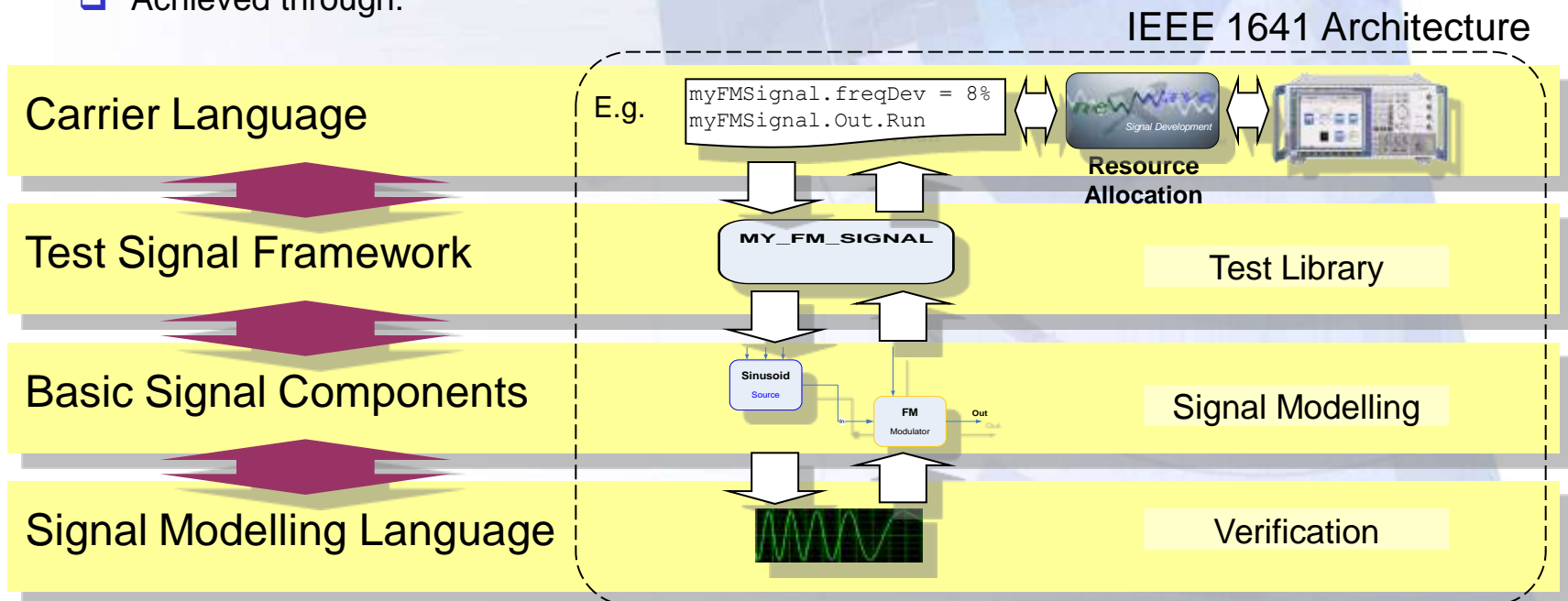


Introduction

IEEE 1641 – Signal & Test Definition

- ❑ Major **objective** has always been ‘**openness**’
 - IEEE 1641 a key element of the UK MoD’s Open System Architecture
 - Choice of TPS development tools, through interoperability
 - TPSs remain optimally portable and resistant to obsolescence

- ❑ Achieved through:



IEEE 1641 – Carrier Language Interfaces

➤ 1641 defines interfaces for:

- ❑ Test program: IDL & TPL
- ❑ Test description: TPL & XML (e.g. ATML Test Description)

➤ Primary methods are:

- ❑ **Require** (<SignalDescriptor>, [UniqueID])
 - SignalDescriptor:
 - BSC (Basic Signal Component)
 - TSF (Test Signal Framework – signal library)
 - XML signal definition (i.e. an 'anonymous TSF')
 - UniqueID, allowing specific resource information to be specified
- ❑ **Run**(timeOut)
- ❑ **Change**(timeOut)
- ❑ **Stop**(timeOut)
- ❑ **.properties**

E.g. Resource Manager with COM interface, IDL

```
// Using my TSF library
AM_SIGNAL myAMSig
myAMSig = Require(AM_SIGNAL)
myAMSig.modIndex = 8%
myAMSig.Out.Run
```

IEEE 1641 – Carrier Language Interfaces

➤ The 1641 methods map to ATML Test Description *Operations*

- E.g. IEEE ATML Test Description

```
<!-- ATML Test Description -->
<Operation xsi:type="OperationSetup" ... >
  <Sensor>
    <LocalSensorSignalReference localSignalID="ls1"/>
    <std:Signal>
      <myTSFLib:AM_SIGNAL name="myAMSig" modIdx="8 %"/>
    </std:Signal>
  </Sensor>
  ...

<Operation xsi:type="OperationConnect" ... >
  <Signal>
    <LocalSignalReference localSignalID="ls1"/>
  </Signal>
  ...
```

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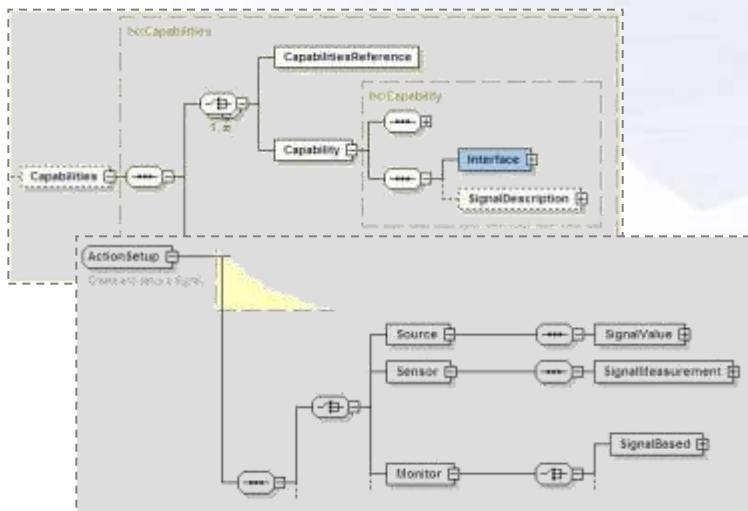


ATML Capability Description

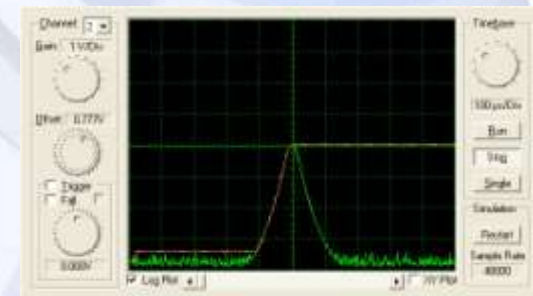
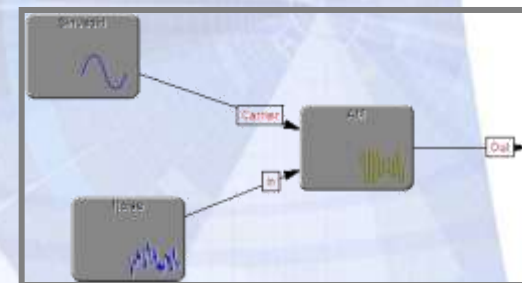
ATML Capability Description

➤ Uses IEEE 1641 Signal Models

ATML Test Station & Instrument Description



IEEE 1641 Signal Models



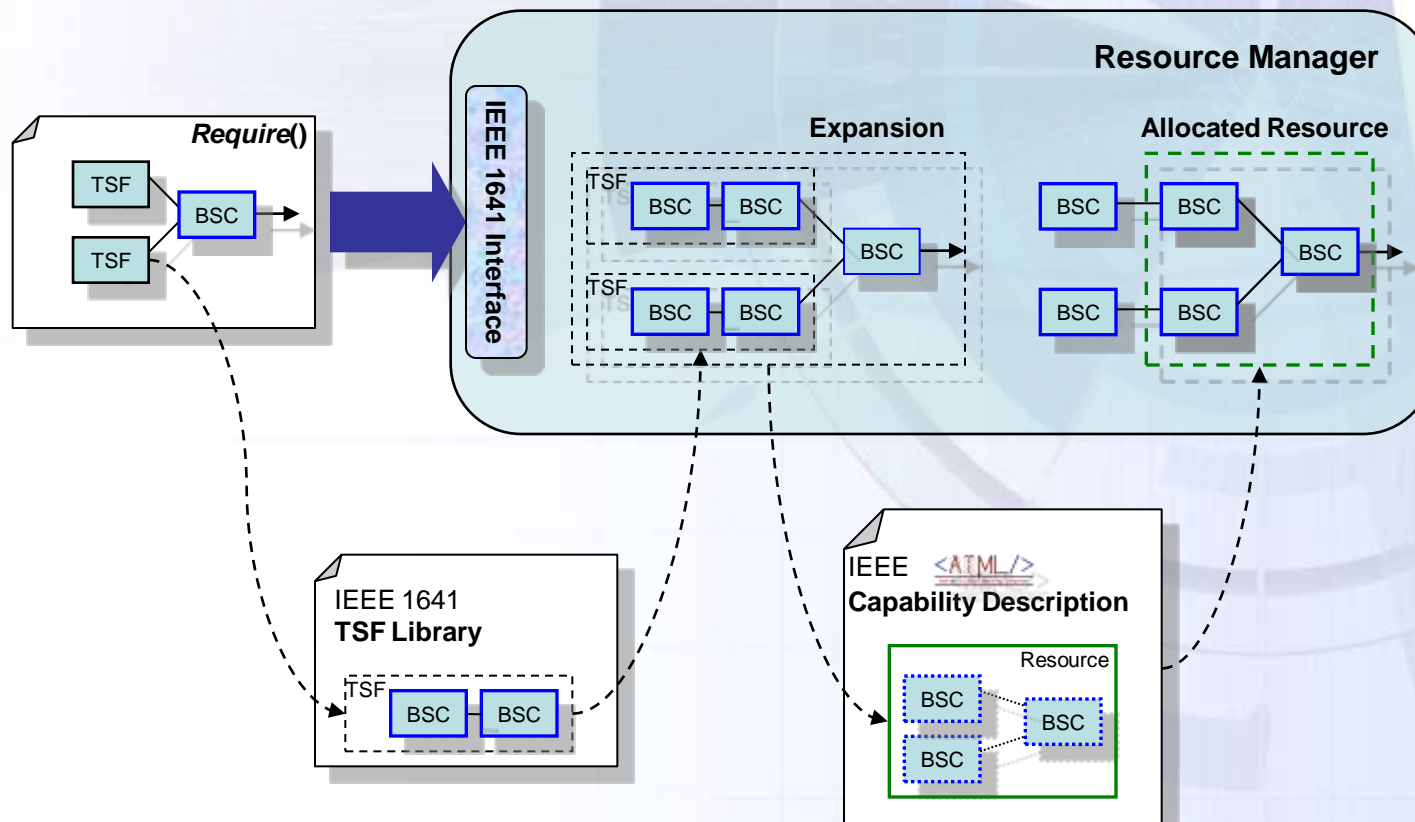
Analogue
Digital
Stimulus
Measurement

ATML Capability Description

➤ Signal-based requirements [optionally expanded]

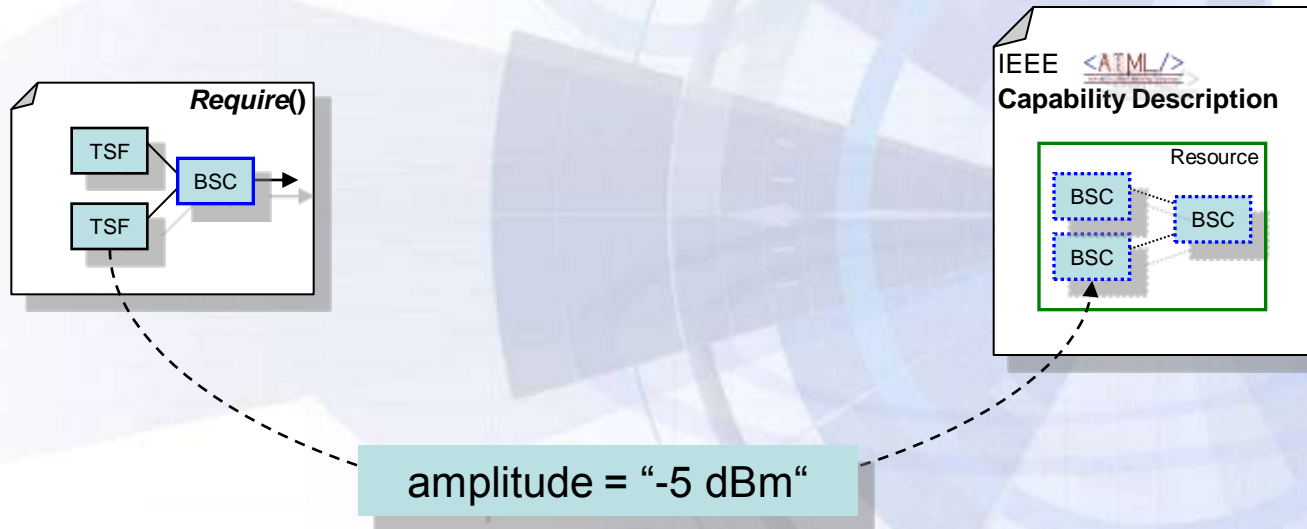
Compared and matched to

➤ Signal-based capabilities



ATML Capability Description

- Signal attributes are similarly transferred to the capability

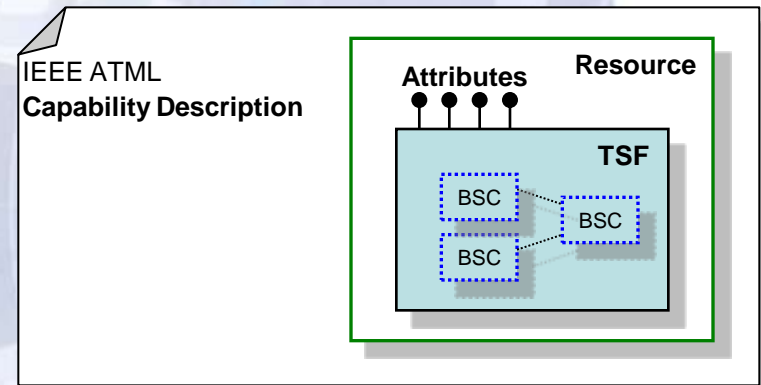


- How can these values be transferred to the parameters of the resource?

- Since, each controllable parameter of a resource maybe bound to more than one signal aspect
- E.g. Three Phase Synchro
Three sinusodal phase attributes, each bound to a single attribute of rotor angle

ATML Capability Description

➤ Resources may be described in terms of TSFs

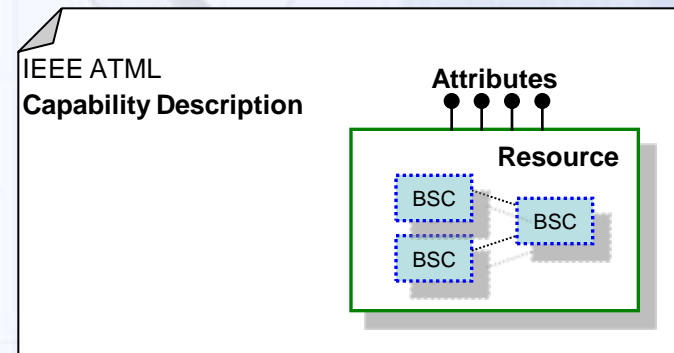


➤ However:

- ❑ TSF attribute formulae propagate towards the signal
- ❑ Resource descriptions require signal properties to propagate towards the controllable resource attributes

∴

Capability descriptions require attributes



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Resource Driver Description

Resource Driver Description

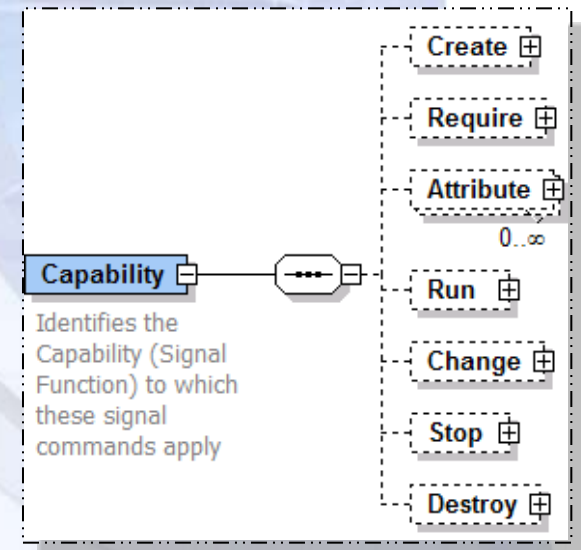
➤ Each of the 1641 interface elements is used to build up a dictionary of driver functions to implement each capability:

- ❑ **Require** (<SignalDescriptor>)
- ❑ **Run**(<timeOut>)
- ❑ **Change**(<timeOut>)
- ❑ **Stop**(<timeOut>)

➤ Additionally:

- ❑ **.attribute**
- ❑ **Create** (to control object lifetimes)
- ❑ **Destroy** (to control object lifetimes)

E.g. Capability Driver Categories

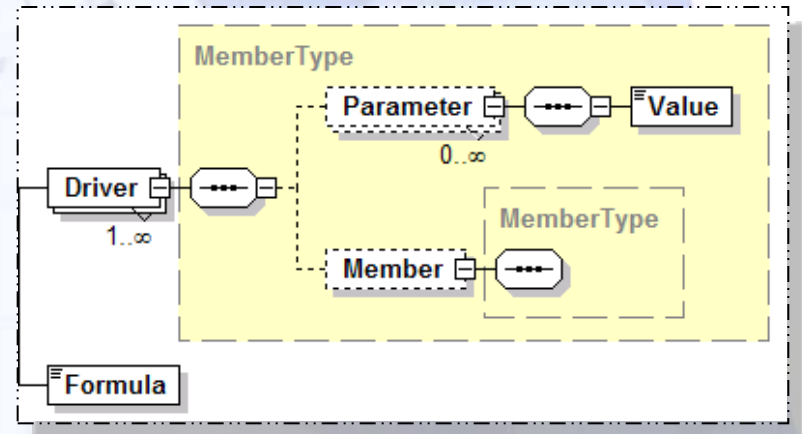


Resource Driver Description

Functions

- Each driver function may, typically, require members, parameters and values
- Additionally, IEEE 1641 formulae support complex mapping and mapping of multiple signal attributes to a given driver parameter
 - E.g. ‘`{{MeasOutputPower.measurement.withUnit(“dBm”).magnitude} - {input_pwr.withUnit(“dBm”).magnitude}}`’

E.g. Capability Driver Members

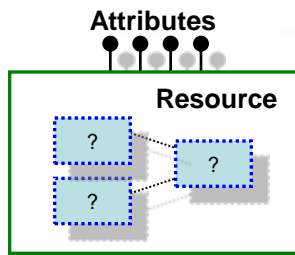
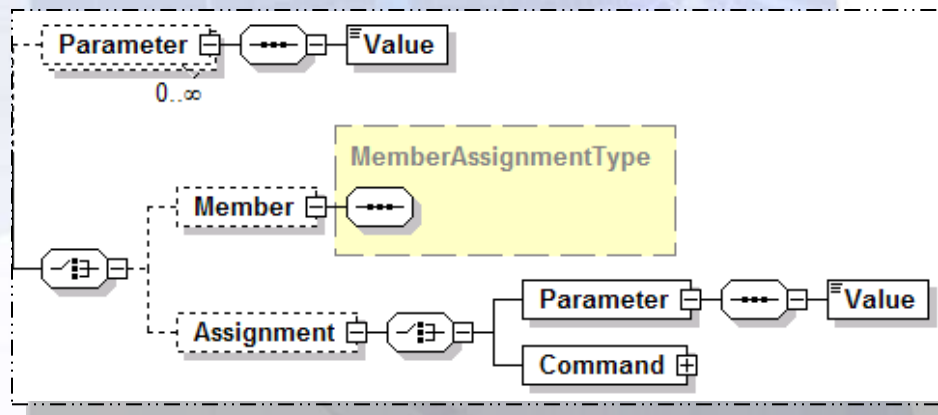


Resource Driver Description

Assignment

- Finally, assignment may, typically, be provided via a parameter value or value obtained through a further driver command

E.g. Capability Driver Assignment



Note: This, additionally, provides capability attributes, absent from ATML Capabilities

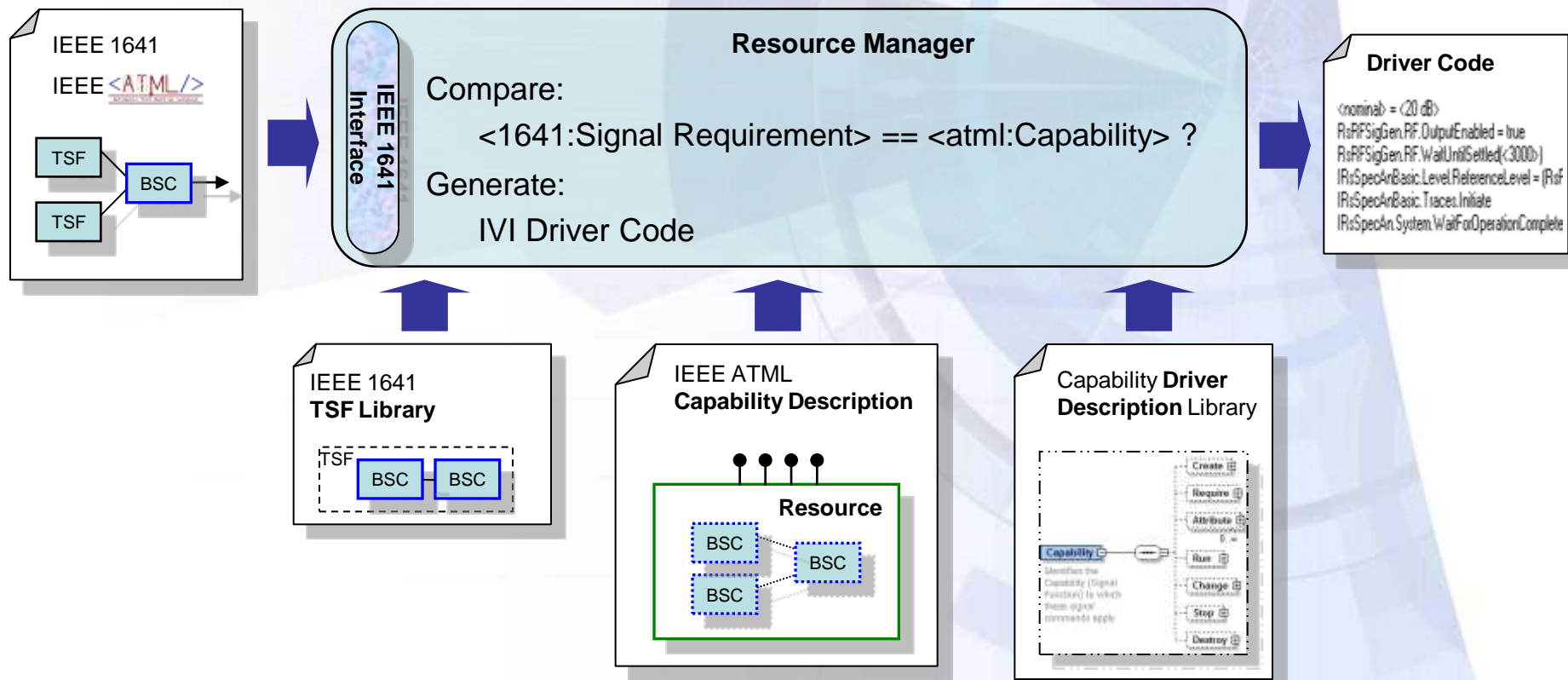
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Compilation

Compilation

➤ Combining the elements described thus far gives the following structure:



Compilation

➤ **1641 Demo II.V** and **ATML Demo** have trialed this process:

- ❑ **Required 1641 Signal is matched to an ATML Capability** of a given resource
- ❑ Identified **resource is located in Resource Driver Description**
- ❑ Each **1641** interface action **yields** a set of driver (IVI) **commands or assignments**.
- ❑ Process **cannot determine** whether the assignment value (e.g. '-20'), is a **literal** or a **variable**. <> denote a possible variable.
- ❑ Doesn't manage **loops** or **conditional** statements
- ❑ Output is generated in a **syntactically independent** form, leaving it open to incorporation into a choice of programming languages

E.g. IVI Driver Commands & Assignments

```
nWXResource
RsRFSigGen.new
RsSpecAn.new

RsSpecAn.Initialize("FSG", true, true, "")
IRsSpecAnBasic = RsSpecAn.Personality.Select("Basic")
RsRFSigGen.Initialize("SMJ", true, true, "")
IRsSpecAnBasic.Frequency.Span = 0
RsSpecAn.System.IO.WriteScpi("CALC:MARK:FUNC:SUM:RMS ON")
RsSpecAnBasic.Acquisition.DetectorType = RsSpecAnBasic.DetectorTypeEnum.Rs
RsSpecAnBasic.SweepCoupling.SweepTime = 0.2
RsSpecAnBasic.Acquisition.SweepModeContinuous = false

RsRFSigGen.RF.Level = <-20>

RsRFSigGen.RF.Frequency = <1500000000>
IRsSpecAnBasic.Frequency.Center = <1500000000>

<nominal> = <20 dB>
RsRFSigGen.RF.OutputEnabled = true
RsRFSigGen.RF.WaitUntilSettled(<3000>)
IRsSpecAnBasic.Level.ReferenceLevel = (RsRFSigGen.RF.Level + <nominal> + 2)
IRsSpecAnBasic.Traces.Initiate
IRsSpecAn.System.WaitForOperationComplete(<3000>)

<measurement_complete> = true

RsRFSigGen.RF.OutputEnabled = false

<measurement> = RsSpecAn.System.IO.QueryScpi(20, "CALC:MARK:FUNC:SUMM
```

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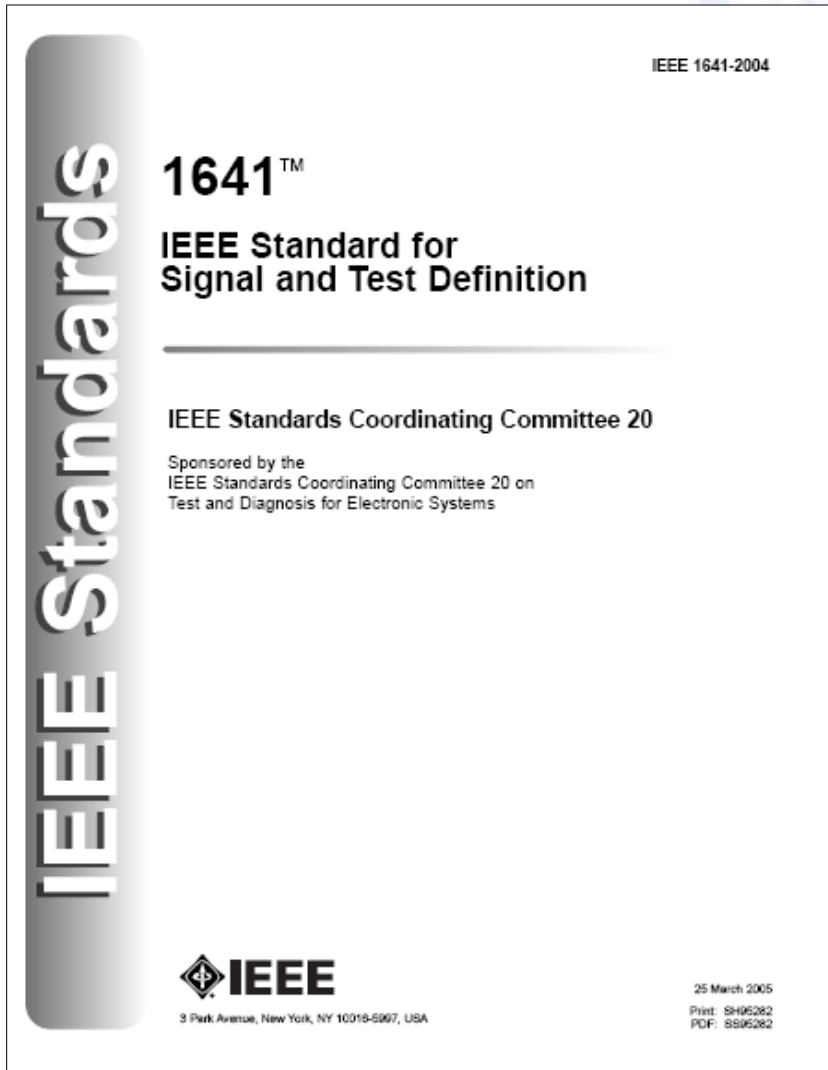


Conclusions

Conclusions

- Architecture described to compile **signals** into native **driver code**
 - ❑ **IEEE 1641**
 - ❑ **ATML** Test Description
- **Open Architecture**, through the 1641 interfaces, IDL, XML & TPL
 - ❑ **Test environments & test languages**
 - ❑ Meets **UK MoD's 'Open System Architecture'** for **portability** and **interoperability**
- **ATML Capability Description** using 1641 signals to **automate resource allocation**
- **XML Resource Driver** document (supplementing ATML Capability), to describe a dictionary of **actions** and **attributes**
- A **compile-time** approach, in **contrast** to previous implementations, which have adopted a **run-time** approach
- Retains the **automatic validation** benefits of the run-time approach, since source documents are XML (including 1641 & ATML)
- In conjunction with **1641 signal modelling** tools, this approach **supports verification** of **resource** performance.

IEEE 1641 – Signal & Test Definition



IEEE 1641-2004


IEEE Standards

1641™

**IEEE Standard for
Signal and Test Definition**

IEEE Standards Coordinating Committee 20

Sponsored by the
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